

**Search Notes****Application/Control No.**

10/662,560

**Examiner**

Alan S. Chen

**Applicant(s)/Patent under Reexamination**

HATANO, NAOYUKI

**Art Unit**

2182

**SEARCHED**

Class	Subclass	Date	Examiner
710	53	1/26/2006	ASC
N	54		
	55		
	56		
	57		
	62	✓	✓
updated		8/13/06	ASC
1united class search			

**INTERFERENCE SEARCHED**

Class	Subclass	Date	Examiner

**SEARCH NOTES  
(INCLUDING SEARCH STRATEGY)**

	DATE	EXMR
(EAST) USPAT; USPGPUB; EPO; JPO; IBM_TDB; DERWENT PLUS; Inventor Search	9/15/2003	ASC
updated EAST	8/13/06	ASC